TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC7MH273FK

#### Octal D-Type Flip Flop with Clear

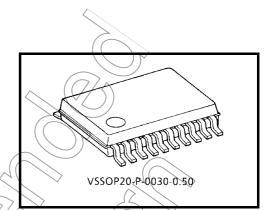
The TC7MH273FK is an advanced high speed CMOS octal D-type flip-flop fabricated with silicon gate  $\rm C^2MOS$  technology.

It achieves the high speed operation similar to equivalent bipolar schottky TTL while maintaining the CMOS low power dissipation.

Information signals applied to D inputs are transferred to the Q outputs on the positive going edge of the clock pulse.

When the  $\overline{\text{CLR}}$  input is held "L", the Q outputs are at a low logic level independent of the other inputs.

An input protection circuit ensures that 0 to 5.5 V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5 V to 3 V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.



Weight: 0.03 g (typ.)

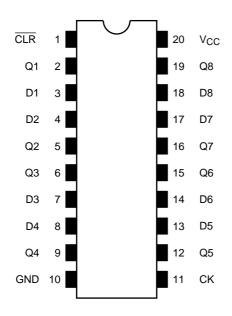
#### **Features**

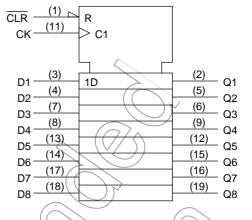
- High speed:  $f_{max} = 165 \text{ MHz}$  (typ.) (V<sub>CC</sub> = 5 V)
- Low power dissipation:  $I_{CC} = 4 \mu A \text{ (max) } (Ta = 25 ^{\circ}\text{C})$
- High noise immunity:  $V_{NIH} = V_{NIL} = 28\% V_{CC}$  (min)
- · Power down protection is provided on all inputs.
- Balanced propagation delays: t<sub>pLH</sub> ≈ t<sub>pHL</sub>
- Wide operating voltage range:  $V_{CC}$  (opr) = 2-5.5 V
- Low noise: VOLP = 0.8 V (max)
- Pin and function compatible with 74ALS273



## Pin Assignment (top view)

## **IEC Logic Symbol**



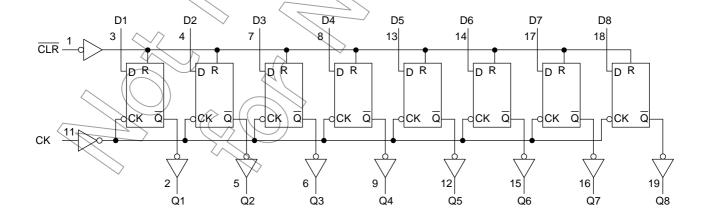


#### **Truth Table**

	Inputs		Outputs	Function
CLR	D	CK	a 2	diction
L	Х	Х		Clear
Н	L		(L(	_
Н	Н		H	
Н	Х	$\rightarrow$	$\left( \left( Q_{n}\right) \right)$	No change

X: Don't care

## **System Diagram**



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#### **Absolute Maximum Ratings (Note)**

Characteristics	Symbol	Rating	Unit
Supply voltage range	Vcc	-0.5~7.0	V
DC input voltage	$V_{IN}$	-0.5~7.0	V
DC output voltage	V <sub>OUT</sub>	-0.5~V <sub>CC</sub> + 0.5	V
Input diode current	Ι <sub>ΙΚ</sub>	-20	mA <
Output diode current	lok	±20	mA
DC output current	lout	±25	mA
DC V <sub>CC</sub> /ground current	Icc	±75	mA
Power dissipation	P <sub>D</sub>	180	mW(_/
Storage temperature	T <sub>stg</sub>	-65~150	\%C\

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Operating Ranges (Note)**

Characteristics	Symbol	Rating	Unit
Supply voltage	V <sub>CC</sub>	2.0~5.5	
Input voltage	V <sub>IN</sub>	0~5.5	
Output voltage	Vout	0~V <sub>CC</sub>	V
Operating temperature	Topr	-40~85	) °C
Input rise and fall time	dt/dv	0-100 ( $V_{CC} = 3.3 \pm 0.3 \text{ V}$ ) 0~20 ( $V_{CC} = 5 \pm 0.5 \text{ V}$ )	/ns/V

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

#### **Electrical Characteristics**

#### **DC Characteristics**

Characteristics		Cumbal	Test Condition <sub>[</sub>			Ta = 25°C			Ta = -40~85°C		Unit	
Charac	tensucs	Symbol	rest Condition		V <sub>CC</sub> (V)	Min	Тур.	Max	Min	Max	Offic	
				2.0	1.50	_	_	1.50	_			
Input voltage	"H" level	V <sub>IH</sub>	$\overline{}$		3.0~5.5	V <sub>CC</sub> × 0.7	_	_	V <sub>CC</sub> × 0.7		V	
input voltage			al		2.0			0.50	_	0.50	V	
	"L" level	V <sub>IL</sub>		<u></u>		_	_	V <sub>CC</sub> × 0.3	_	V <sub>CC</sub> × 0.3		
					2.0	1.9	2.0	-	1.9			
		V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub>	I <sub>OH</sub> = -50 μA	3.0	2.9	3.0	_	2.9	-		
	"H" level				4.5	4.4	4.5		4.4	1		
				$I_{OH} = -4 \text{ mA}$	3.0	2.58	_	_	2.48			
Output				$I_{OH} = -8 \text{ mA}$	4.5	3.94	_	_	3.80	-	V	
voltage					2.0	1	0	0.1	_	0.1	V	
			., .,	$I_{OL} = 50 \mu A$	3.0	-	0	0.1	—	0.1		
	"L" level	$V_{OL}$	$V_{IN} = V_{IH}$ or $V_{IL}$		4.5		0	0.1		0.1		
				$I_{OL} = 4 \text{ mA}$	3.0	1		0.36	_	0.44		
				$I_{OL} = 8 \text{ mA}$	4.5			0.36		0.44		
Input leakage of	current	I <sub>IN</sub>	V <sub>IN</sub> = 5.5 V or GND		0~5.5	_		±0.1	_	±1.0	μΑ	
Quiescent supp	ply current	Icc	$V_{IN} = V_{CC}$	or GND	5.5	_	_	4.0	_	40.0	μΑ	

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# Timing Requirements (Input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics	Symbol	Test Condition		Ta = 25°C		Ta = -40~85°C	Unit
Characteristics	Symbol		V <sub>CC</sub> (V)	Тур.	Limit	Limit	Onit
Minimum pulse width	t <sub>w (L)</sub>	_	$3.3 \pm 0.3$		5.5	6.5	ns
(CK)	t <sub>w (H)</sub>	_	$5.0 \pm 0.5$		5.0	5.0	113
Minimum pulse width	4		$3.3 \pm 0.3$	_ `	5.0	6.0	ns
(CLR)	t <sub>w (L)</sub>	_	$5.0 \pm 0.5$	_	(5.0	5.0	115
Minimum set-up time	t <sub>s</sub>		$3.3 \pm 0.3$		5.5	6.5	ns
		_	5.0 ± 0.5	$+ \bigcirc$	4.5	4.5	115
Minimum hold time	4.		$3.3 \pm 0.3$	7//	_1.0	1.0	ns
wiinimum noid time	t <sub>h</sub>	_	5.0 ± 0(5(	7	1.0	1.0	115
Minimum removal time	+		$3.3 \pm 0.3$	))	2.5	2.5	ns
( CLR )	t <sub>rem</sub>	_	$5.0 \pm 0.5$	<u> </u>	2.0	2.0	115

#### AC Characteristics (Input: $t_r = t_f = 3$ ns)

Observant and all an	Complete Test Condition				Ta = 25°C		Ta = -40~85°C		- Unit	
Characteristics	Symbol Test Condition	Test Condition	V <sub>CQ</sub> (V)	C <sub>L</sub> (pF)	Min	Typ.	Max	Min	Max	Offic
			$3.3 \pm 0.3$	15	_	8.7	13.6	1.0	16.0	
Propagation delay time	t <sub>pLH</sub>		0.5 ± 0.5	<sup>→</sup> 50	-	(11.2)	17.1	1.0	19.5	ns
(CK-Q)	tpHL	_ ((	5.0 ± 0.5	15		5.8	9.0	1.0	10.5	113
			3.0 1 0.3	50 (	_	7.3	11.0	1.0	12.5	
			$3.3 \pm 0.3$	15		8.9	13.6	1.0	16.0	ns
Propagation delay time	t <sub>pHL</sub>		0.0 ± 0.0	50		11.4	17.1	1.0	19.5	
(CLR -Q)		5.0 ± 0.5	15	_	5.2	8.5	1.0	10.0	113	
			0.0 ± 0.0	50	\ —	6.7	10.5	1.0	12.0	
	f <sub>max</sub> —	3.3 ± 0.3	15	75	120	_	65	_		
Maximum clock frequency/			(7)	√ 50	50	75	_	45	_	MHz
Maximum stock frequency	- Illiax		5.0 ± 0.5	)) 15	120	165	_	100	_	
	<u>~</u>		0,0 = 0.0	50	80	110	_	70	_	
Output to output skew	tosLH	(Note 1)	$3.3 \pm 0.3$	50	_	_	1.5	_	1.5	ns
	tosHL	(110101)	$5.0 \pm 0.5$	50	_	_	1.0	_	1.0	110
Input capacitance	C <sub>IN</sub>	-	_		_	4	10	_	10	pF
Power dissipation capacitance	C <sub>PD</sub>			(Note 2)	_	31	_	_	_	pF

Note 1: This parameter is guaranteed by design.

tosch = |tplhm - tplhn|, toshl = |tphlm - tphln|

Note 2: CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

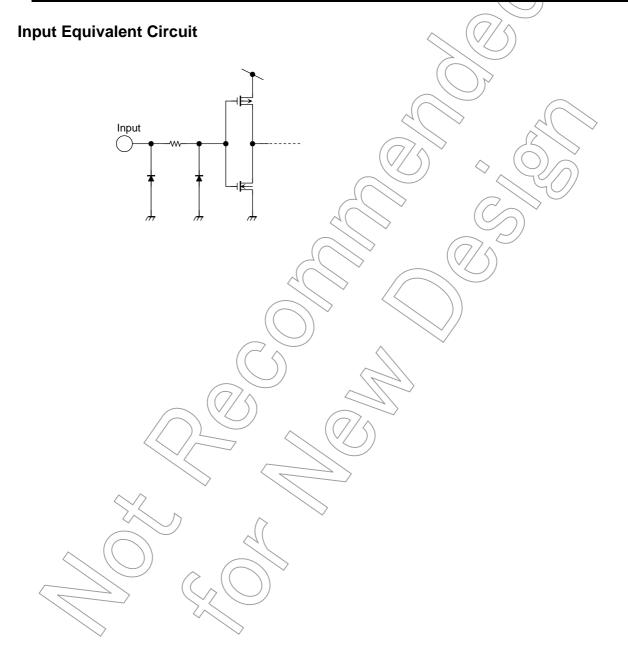
 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 (per F/F)$ 

And the total CPD when n pcs of flip-flop operate can be gained by the following equation:

 $C_{PD}$  (total) = 22 + 9 · n

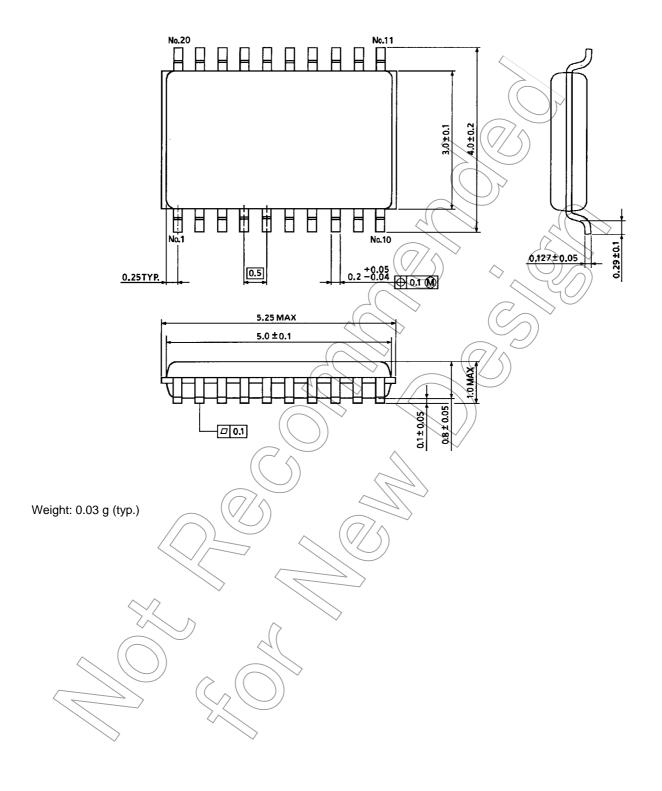
# Noise Characteristics (Input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics	Symbol	Test Condition		Ta = 25°C		- Unit
Characteristics	Symbol	rest Condition	V <sub>CC</sub> (V)	Тур.	Limit	Offic
Quiet output maximum dynamic V <sub>OL</sub>	V <sub>OLP</sub>	C <sub>L</sub> = 50 pF	5.0	0.5	0.8	V
Quiet output minimum dynamic V <sub>OL</sub>	V <sub>OLV</sub>	C <sub>L</sub> = 50 pF	5.0	-0.5	-0.8	V
Minimum high level dynamic input voltage $V_{\text{IH}}$	V <sub>IHD</sub>	C <sub>L</sub> = 50 pF	5.0	_	3.5	V
Maximum low level dynamic input voltage $V_{\text{IL}}$	V <sub>ILD</sub>	C <sub>L</sub> = 50 pF	5.0	4	1.5	V



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## **Package Dimensions**



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2007-10-19